

	Hits	Search Text	DBs	Time Stamp
29	14	(class adj "D") and (switch\$3 with frequenc\$3) and (leakage\$1 near3 inductance) and (low adj pass)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/10 11:40
30	13	(class adj "D") and (switch\$3 with frequenc\$3) and (transformer with leakage\$1 with inductance) and (low adj pass)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/10 12:00
31	2	(class adj "D") and (switch\$3 with frequenc\$3) and (transformer with leakage\$1 with inductance with (low adj pass))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/10 12:00
32	1	(class adj "D") same ((leakage near inductance) with minimiz\$3 with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:24
33	1	(class adj "D") same ((leakage near inductance) with minimiz\$3 with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:06

	Hits	Search Text	DBs	Time Stamp
34	1	(class adj "D") same ((leakage near inductance) with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 16:58
35	6	(class adj "D") and ((leakage near inductance) with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 16:58
36	1	(class adj "D") and ((leakage near inductance) with minimiz\$3 with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 16:59
37	6	(class adj "D") and ((leakage near inductance) with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 16:59
38	0	(class adj "D") same ((stray near capacitor) with minimiz\$3 with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:06
39	1	(class adj "D") same (capacitor with minimiz\$3 with resonance)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:06
40	5	(class adj "D") and ((leakage near inductance) with (low near pass))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:30

	Hits	Search Text	DBs	Time Stamp
41	0	(class adj "D") and ((leakage near inductance) same (low near pass) same capcitor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:31
42	5	(class adj "D") and ((leakage near inductance) same (low near pass) same capacitor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	2005/11/11 17:31